Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/544,120	BONNER ET AL.	
Examiner	Art Unit	
Seung H. Lee	2876	

	SEARCHED				
Class	Subclass	Date	Examiner		
235	462.08	10/28/2005	SHL		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
Same as	Above	10/28/2005	SHL	
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SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
235/462.01,462.25,462.41 (see printouts)	10/28/2005	SHL
235/472.01,472.02 (see printouts)	10/28/2005	SHL
C. Labelle (SPRE)	10/28/2005	SHL
С. Spyrou	10/28/2005	SHL
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